

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/579,086	KROON, ARIE	
Examiner		Art Unit		Page 1 of 1
JASON HECKERT		1711		

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*	B	US-2004/0118291	06-2004	Carhuff et al.	099/275
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	J	US-			
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	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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